

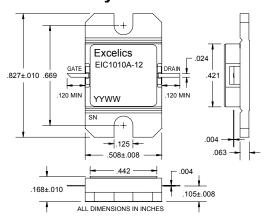
EIC1010A-12

ISSUED: 07/24/2007

10.0-10.25 GHz 12-Watt Internally Matched Power FET

FEATURES

- 10.0-10.25GHz Bandwidth
- Input/Output Impedance Matched to 50 Ohms
- +40.5dBm Output Power at 1dB Compression
- 7.0 dB Power Gain at 1dB Compression
- 30% Power Added Efficiency
- Hermetic Metal Flange Package





Caution! ESD sensitive device.

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

SYMBOL	PARAMETERS/TEST CONDITIONS ¹		TYP	MAX	UNITS
P _{1dB}	Output Power at 1dB Compression $f = 10.0-10.25GHz$ $V_{DS} = 9 \text{ V}, I_{DSQ} \approx 3200\text{mA}$	39.5	40.5		dBm
G _{1dB}	Gain at 1dB Compression $f = 10.0-10.25GHz$ $V_{DS} = 9 \text{ V}, I_{DSQ} \approx 3200\text{mA}$	6.0	7.0		dB
ΔG	Gain Flatness $f = 10.0-10.25GHz$ $V_{DS} = 9 \text{ V}, I_{DSQ} \approx 3200\text{mA}$			±0.5	dB
PAE	Power Added Efficiency at 1dB Compression V_{DS} = 9 V, $I_{DSQ} \approx 3200$ mA f = 10.0-10.25GHz		30		%
Id _{1dB}	Drain Current at 1dB Compression f = 10.0-10.25GHz		3300	3700	mA
IM3	Output 3rd Order Intermodulation Distortion Δf =10MHz 2-Tone Test. Pout=28.5 dBm S.C.L Vds = 9 V, I _{DSQ} ≈ 65% I _{DSS} f = 10.25GHz		-43		dBc
I _{DSS}	Saturated Drain Current V _{DS} = 3 V, V _{GS} = 0 V		5800	7200	mA
V _P	Pinch-off Voltage V _{DS} = 3 V, I _{DS} = 58 mA		-2.5	-4.0	V
R _{TH}	Thermal Resistance ³		2.3	2.6	°C/W

Note: 1) Tested with 50 Ohm gate resistor.

2) S.C.L. = Single Carrier Level.

3) Overall Rth depends on case mounting

ABSOLUTE MAXIMUM RATING^{1,2}

SYMBOLS	PARAMETERS	ABSOLUTE1	CONTINUOUS ²
Vds	Drain-Source Voltage	15	10V
Vgs	Gate-Source Voltage	-5	-4V
lgsf	Forward Gate Current	130mA	43mA
lgsr	Reverse Gate Current	-21mA	-7mA
Pin	Input Power	40.0dBm	@ 3dB Compression
Tch	Channel Temperature	175°C	175 °C
Tstg	Storage Temperature	-65 to +175 °C	-65 to +175 °C
Pt	Total Power Dissipation	57W	57W

Note: 1. Exceeding any of the above ratings may result in permanent damage.

^{2.} Exceeding any of the above ratings may reduce MTTF below design goals.



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- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness